

Notice of References Cited	Application/Control No. 10/715,045		Applicant(s)/Patent Under Reexamination SENDYK ET AL.	
	Examiner Yuwen Pan		Art Unit 2618	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,006,804	02-2006	Clark et al.	455/105
*	B	US-6,594,473	07-2003	Dabak et al.	455/101
*	C	US-2001/0004585	06-2001	Tsujimoto, Ichiro	455/101
*	D	US-2003/0114108	06-2003	Frecassetti et al.	455/61
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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